Philips Components-Signetics

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Memory Produ	icts

82S137 4K-bit TTL bipolar PROM

DESCRIPTION

The 82S137 is field programmable, which means that custom patterns are immediately available by following the Signetics Generic I fusing procedure. The 82S137 is supplied with all outputs at logical Low. Outputs are programmed to a logic High level at any specified address by fusing the Ni-Cr link matrix.

This device includes on-chip decoding and 2 Chip Enable inputs for ease of memory expansion. It features 3-State outputs for optimization of word expansion in bused organizations.

Ordering information can be found on the following page.

The 82S137 device is also processed to military requirements for operation over the military temperature range, for specifications and ordering information consult the Signetics Military Data Handbook.

FEATURES

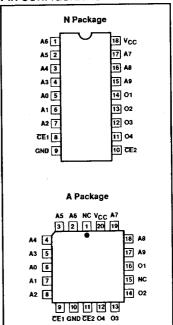
- Address access time: 60ns max
- Power dissipation: 0.13mW/bit typ
- Input loading: -100µA max
- On-chip address decoding
- No separate fusing pins
- Unprogrammed outputs are Low level
- Fully TTL compatible
- Two Chip Enable inputs
- Outputs: 3-State

APPLICATIONS

- Sequential controllers
- Control store
- Random logic
- Code conversion

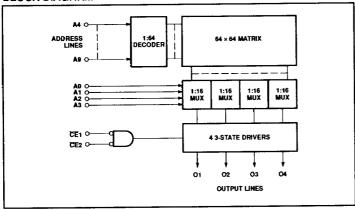
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PIN CONFIGURATIONS



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BLOCK DIAGRAM



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4K-bit TTL bipolar PROM (1024 \times 4)

82S137

ORDERING INFORMATION

DESCRIPTION	ORDER CODE
18-Pin Plastic Dual-In-Line 300mil-wide	N82S137 N
20-Pin Plastic Leaded Chip Carrier 350mil-square	N82S137 A

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	+7.0	V _{DC}
V _{IN}	Input voltage	+5.5	V _{DC}
Vo	Output voltage Off-State	+5.5	V _{DC}
T _{amb}	Operating temperature range	0 to +75	°C
T _{sta}	Storage temperature range	-65 to +150	°C

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DC ELECTRICAL CHARACTERISTICS

T I			LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS ^{1,2}	Min	Typ ³	Max	UNIT
Input volt	age					
V _{IL}	Low	Detecheratelle		0.8	٧	
V _{IH}	High	DataSheet4U.com	2.0	1		٧
V _{IC}	Clamp	I _{IN} = -12mA			-1.2	٧
Output vo	oltage					
		CE1,2 = Low				
V_{OL}	Low	I _{OUT} = 16mA			0.45	٧
V_{OH}	High .	I _{OUT} = -2mA	2.4			٧
Input curi	rent					
I _{IL}	Low	V _{IN} = 0.45V			-100	μΑ
I _{IH}	High	V _{IN} = 5.5V			40	μA
Output cu	urrent					
I _{OZ} Hi-Z	Hi-Z state	CE1,2 = High, V _{OUT} = 0.5V			-40	μΑ
	i	CE1,2 = High, V _{OUT} = 5.5V			40	μΑ
los	Short circuit ⁴	CE1,2 = Low, V _{OUT} = 0V, High stored	-15		-70	mA
Supply cu	urrent ⁵					
lcc		V _{CC} = 5.25V			140	mA
Capacitar	nce					
		CE1,2 = High, V _{CC} = 5.0V				
CiN	Input	V _{IN} = 2.0V	1	5	1	pF
C _{OUT}	Output	V _{OUT} = 2.0V	1	8		рF

NOTES:

- 1. Positive current is defined as into the terminal referenced.
- 2. All voltages with respect to network ground.
- Typical values are at V_{CC} = 5V, T_{amb} = +25°C.
 Duration of short circuit should not exceed 1 second.
- 5. Measured with all inputs grounded and all outputs open.

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4K-bit TTL bipolar PROM (1024 \times 4)

82S137

AC ELECTRICAL CHARACTERISTICS

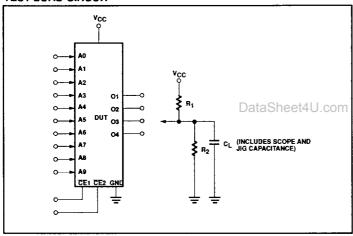
 $R_1 = 270\Omega$, $R_2 = 600\Omega$, $C_L = 30pF$, $0^{\circ}C \le T_{amb} \le +75^{\circ}C$, $4.75V \le V_{CC} \le 5.25V$

SYMBOL	PARAMETER	то	FROM	LIMITS			
				Min	Typ1	Max	UNIT
Access time	2						
t _{AA}		Output	Address		40	60	ns
t _{CE}		Output [®]	Chip Enable		25	30	ns
Disable time	3						
tcp		Output	Chip Disable		25	30	ns

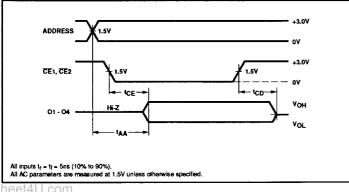
NOTES:

- 1. Typical values are at V_{CC} = 5V, T_{amb} = +25°C. 2. Tested at an address cycle time of 1 µs. 14.0. 3 Measured at a delta of 0.5V from Logic Level with R_1 = 750 Ω , R_2 = 750 Ω , C_L = 5pF.

TEST LOAD CIRCUIT



VOLTAGE WAVEFORMS



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